

FCC TEST REPORT (RFID)

 REPORT NO.:
 RF130805C29-6

 MODEL NO.:
 0P3P510

 FCC ID:
 NM80P3P510

 RECEIVED:
 Aug. 05, 2013

 TESTED:
 Aug. 26, 2013 ~ Sep. 01, 2013

 ISSUED:
 Sep. 09, 2013

APPLICANT: HTC Corporation

ADDRESS: No. 23, Xinghua Rd., Taoyuan 330, Taiwan, R.O.C.

ISSUED BY: Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch

- LAB ADDRESS: No. 47, 14th Ling, Chia Pau Vil., Lin Kou Dist., New Taipei City, Taiwan, R.O.C.
- **TEST LOCATION:** No. 19, Hwa Ya 2nd Rd, Wen Hwa Tsuen, Kwei Shan Hsiang, Taoyuan Hsien 333, Taiwan, R.O.C.

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	LAB 31	



RELEASE CONTROL RECORD

ISSUE NO.	REASON FOR CHANGE	DATE ISSUED
RF130805C29-6	Original release	Sep. 09, 2013



1. CERTIFICATION

PRODUCT:SmartphoneMODEL:0P3P510BRAND:HTCAPPLICANT:HTC CorporationTESTED:Aug. 26, 2013 ~ Sep. 01, 2013TEST SAMPLE:Production UnitSTANDARDS:FCC Part 15, Subpart C (Section 15.225)FCC Part 15, Subpart C (Section 15.215)ANSI C63.10-2009

The above equipment (model: 0P3P510) has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Vera Huang

, DATE : Sep. 09, 2013

Vera Huang / Specialist

APPROVED BY

PREPARED BY

DATE : Sep. 09, 2013

Sam Chen / Assistant Manager



2. SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specifications:

APPLI	APPLIED STANDARD: FCC PART 15, SUBPART C (SECTION 15.225, 15.215)					
STANDARD TEST TYPE AND LIMIT		RESULT	REMARK			
15.207	Conducted emission test	PASS	Meet the requirement of limit. Minimum passing margin is -4.09dB at 13.55859MHz.			
15.225 (a)	The field strength of any emissions within the band 13.553-13.567 MHz	PASS	Meet the requirement of limit. Minimum passing margin is -68.63dB at 13.56MHz.			
15.225 (d)	The field strength of any emissions appearing outside of the 13.110-14.010 MHz band	PASS	Meet the requirement of limit. Minimum passing margin is -4.87dB at 40.53MHz.			
15.225 (e)	The frequency tolerance	PASS	Meet the requirement of limit.			
15.215 (c)	20dB Bandwidth	PASS	Meet the requirement of limit.			

2.1 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

MEASUREMENT	FREQUENCY	UNCERTAINTY
Conducted Emission	150kHz ~ 30MHz	2.44 dB
Redicted omissions	30MHz ~ 200MHz	3.34 dB
Radiated emissions	200MHz ~1000MHz	3.35 dB

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



3. GENERAL INFORMATION

3.1 GENERAL DESCRIPTION OF EUT

EUT	Smartphone	
MODEL NO.	0P3P510	
POWER SUPPLY	5.0Vdc (adapter or host equipment) 3.8Vdc (Li-ion battery)	
MODULATION TYPE	ASK	
OPERATING FREQUENCY	13.56MHz	
ANTENNA TYPE	Loop Antenna	
DATA CABLE	Refer to Note	
I/O PORTS	Refer to user's manual	
ACCESSORY DEVICES	Refer to Note	

NOTE:

1. The EUT's accessories list refers to Ext. Pho.

2. The above EUT information is declared by the manufacturer and for more detailed features description, please refer to the manufacturer's specifications or User's Manual.



3.2 DESCRIPTION OF TEST MODES

3.2.1 TEST MODE APPLICABILITY AND TESTED CHANNEL DETAIL

EUT CONFIGURE MODE			APPLIC	ABLE TO		DECODUCTION
		RE	PLC	FS	BW	DESCRIPTION
-		\checkmark	\checkmark	\checkmark	\checkmark	-
Where	RE:	Radiated Emission PLC: Power Line Conducted Emission				
	FS: Frequency Stability		bility E	BW: 20dB Band	lwidth	

NOTE:

The EUT had been pre-tested on the positioned of each 3 axis. The worst case was found when positioned on **Z-plane**.

RADIATED EMISSION TEST:

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EUT CONFIGURE MODE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TYPE
-	1	1	ASK

POWER LINE CONDUCTED EMISSION TEST:

The EUT was tested with the following mode.

TEST CONDITION		
BT LE 4.0 Link + WLAN (5G) Link + NFC Link + USB Cable + Adapter + E	arphone	

FREQUENCY STABILITY:

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EUT CONFIGURE MODE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TYPE
-	1	1	ASK



20dB BANDWIDTH:

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EUT CONFIGURE MODE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TYPE
-	1	1	ASK

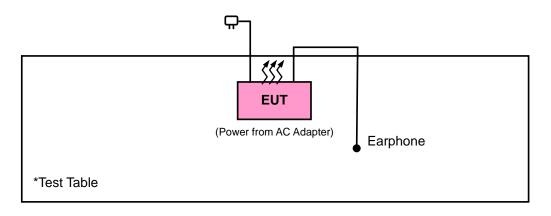
TEST CONDITION:

APPLICABLE TO	ENVIRONMENTAL CONDITIONS	INPUT POWER	TESTED BY
RE	25deg. C, 65%RH	120Vac, 60Hz	David Huang
FS	25deg. C, 65%RH	120Vac, 60Hz	Howard Kao
PLC	25deg. C, 65%RH	120Vac, 60Hz	Johnson Liao
BW	25deg. C, 65%RH	120Vac, 60Hz	Howard Kao

3.3 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units.

3.3.1 CONFIGURATION OF SYSTEM UNDER TEST





3.4 GENERAL DESCRIPTION OF APPLIED STANDARDS

The EUT is a RFID Product. According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

FCC Part 15, Subpart C (15.225) FCC Part 15, Subpart C (15.215) ANSI C63.10-2009

All test items have been performed and recorded as per the above standards.

NOTE: The EUT is also considered as a kind of computer peripheral, because the connection to computer is necessary for typical use. It has been verified to comply with the requirements of FCC Part 15, Subpart B, Class B. The test report has been issued separately.



4. TEST TYPES AND RESULTS

4.1 RADIATED EMISSION MEASUREMENT

4.1.1 LIMITS OF RADIATED EMISSION MEASUREMENT

The field strength of any emissions within the band 13.553-13.567 MHz shall not exceed 15,848 microvolts/meter at 30 meters.

The field strength of any emissions appearing outside of the 13.110-14.010 MHz band shall not exceed the general radiated emission limits in § 15.209.

FREQUENCIES (MHz)	FIELD STRENGTH (microvolts/meter)	MEASUREMENT DISTANCE (meters)
0.009 ~ 0.490	2400/F(kHz)	300
0.490 ~ 1.705	24000/F(kHz)	30
1.705 ~ 30.0	30	30
30 ~ 88	100	3
88 ~ 216	150	3
216 ~ 960	200	3
Above 960	500	3

NOTE:

- 1. The lower limit shall apply at the transition frequencies.
- 2. Emission level (dBuV/m) = 20 log Emission level (uV/m).
- 3. As shown in 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector, however, the peak field strength of any emission shall not exceed the maximum permitted average limits, specified above by more than 20dB under any condition of modulation.



4.1.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	DATE OF CALIBRATION	DUE DATE OF CALIBRATION
Test Receiver ROHDE & SCHWARZ	ESCI	100744	Apr. 15, 2013	Apr. 14, 2014
Spectrum Analyzer ROHDE & SCHWARZ	FSU43	101261	Dec. 17, 2012	Dec. 16, 2013
BILOG Antenna SCHWARZBECK	VULB9168	9168-472	Mar. 25, 2013	Mar. 24, 2014
HORN Antenna SCHWARZBECK	BBHA 9120 D	9120D-969	Jan. 07, 2013	Jan. 06, 2014
Preamplifier EMCI	EMC 012645	980115	Dec. 28, 2012	Dec. 27, 2013
Preamplifier EMCI	EMC 184045	980116	Dec. 28, 2012	Dec. 27, 2013
Preamplifier EMCI	EMC 330H	980112	Dec. 28, 2012	Dec. 27, 2013
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	309219/4	Oct. 19, 2012	Oct. 18, 2013
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	250130/4	Oct. 19, 2012	Oct. 18, 2013
RF signal cable Worken	RG-213	NA	Dec. 29, 2012	Dec. 28, 2013
Software BV ADT	E3 6.120103	NA	NA	NA
Antenna Tower MF	MFA-440H	NA	NA	NA
Turn Table MF	MFT-201SS	NA	NA	NA
Antenna Tower &Turn Table Controller MF	MF-7802	NA	NA	NA

NOTE: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The calibration interval of the loop antenna is 24 months and the calibrations are traceable to NML/ROC and NIST/USA.

3. The test was performed in HwaYa Chamber 10.

4. The FCC Site Registration No. is 690701.

5. The IC Site Registration No. is IC 7450F-10.



4.1.3 TEST PROCEDURES

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength.
 Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
- f. If the emission level of the EUT in peak mode was lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

NOTE:

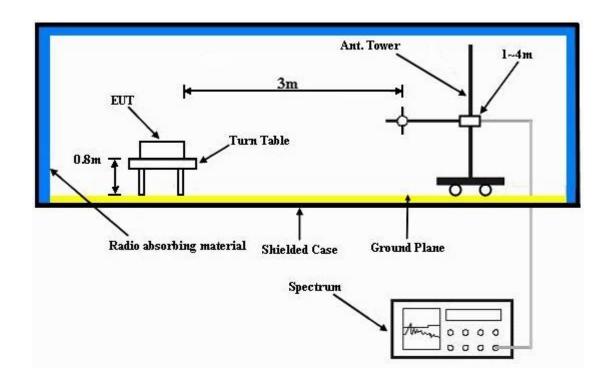
- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for Quasi-peak detection at frequency below 1GHz.
- 2. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and video bandwidth is 3MHz for Peak detection at frequency above 1GHz.
- 3. All modes of operation were investigated and the worst-case emissions are reported.

4.1.4 DEVIATION FROM TEST STANDARD

No deviation.



4.1.5 TEST SETUP



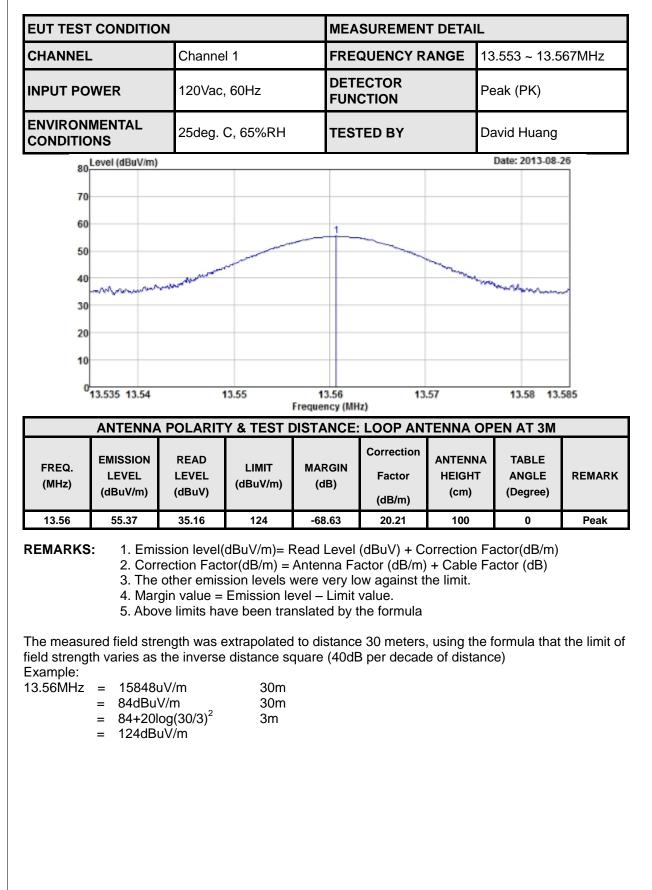
For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.1.6 EUT OPERATING CONDITIONS

Set the EUT under transmission condition continuously at specific channel frequency.



4.1.7 TEST RESULTS





-UT IES	T CONDITIO	Ν		MEA	SUREMEN	T DETAIL			
CHANNEI	L	Channe	el 1	FRE	QUENCY R	ANGE 1	3.553 ~ 13.5	67MHz	
NPUT PC	OWER	120Vac	, 60Hz		ECTOR CTION	Р	eak (PK)		
ENVIRON	IMENTAL ONS	25deg.	C, 65%RH	TES	TED BY	D	David Huang		
	0 Level (dBuV/m)						Date: 2013-08-	26	
50	0							_	
40 30 20 10	0 0	and and an and a second	13.55	13.56	13	.57	13.58 13.	.585	
30 20	0 0			13.56 Frequency (Mi				.585	
30 20	0 0			Frequency (M	Hz)	.57	13.58 13.		
30 20	0 0 0 0 13.535 13.54			Frequency (M	Hz)	.57	13.58 13.		

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Collection Factor(dB/m)

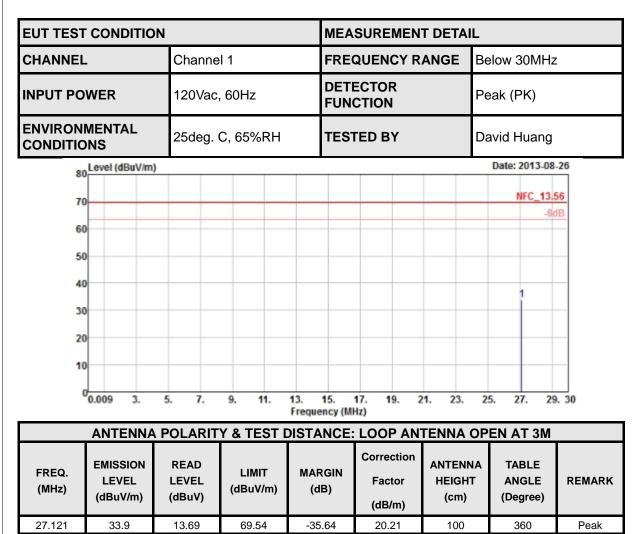
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value.

5. Above limits have been translated by the formula

The measured field strength was extrapolated to distance 30 meters, using the formula that the limit of field strength varies as the inverse distance square (40dB per decade of distance) Example:

13.56MHz	=	15848uV/m	30m
		84dBuV/m	30m
	=	84+20log(30/3) ²	3m
	=	124dBuV/m	





REMARKS:

1. Emission level(dBuV/m)= Read Level (dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value.



EUT TEST	CONDITI	NC		MEA	SUREMEN	T DETAI	L		
CHANNEL		Channe	el 1	FRE	QUENCY R	ANGE	Below	30MHz	2
	WER	120Vac	e, 60Hz		ECTOR CTION		Peak (PK)		
ENVIRONI CONDITIO		25deg.	C, 65%RH	TES	TED BY		David I	Huang	
80	Level (dBuV/n	1)					Date:	2013-08-	26
70								NFC_13.5	56
								-6d	B
60									_
50									-
40							_	1	_
30									
20									_
10									_
o	0.009 3.	5. 7.	9. 11.	13. 15. Frequency (M		1. 23.	25. 2	27. 29	. 30
	ANTENNA		Y & TEST D	ISTANCE:	LOOP ANT	ENNA (LOSE	AT 3M	
FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	READ LEVEL (dBuV)	LIMIT (dBuV/m)	MARGIN (dB)	Correction Factor (dB/m)	ANTENN HEIGH (cm)	T A	ABLE NGLE egree)	REMARK
	35.38	15.17	69.54	-34.16	20.21	100	-	0	Peak

REMARKS: 1. Emission level(dBuV/m)= Read Level (dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

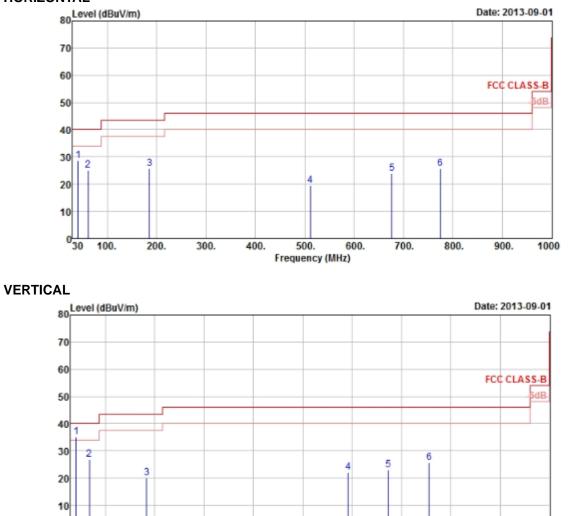
3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value.



EUT TEST CONDITION		MEASUREMENT DETAIL			
CHANNEL	Channel 1	FREQUENCY RANGE	30MHz ~ 1GHz		
INPUT POWER 120Vac, 60 Hz			Peak (PK) Quasi-peak (QP)		
ENVIRONMENTAL CONDITIONS	25deg. C, 65%RH	TESTED BY	David Huang		

HORIZONTAL



030

100.

200.

300.

400.

500.

Frequency (MHz)

700.

800.

900.

1000

600.



	AN	TENNA	POLARIT	Y & TES	T DISTAN	ICE: HO	RIZONTA	AL AT 3 M		
FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	READ LEVEL (dBuV)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA FACTOR (dB/m)	CABLE LOSS (dB)	PREAMP FACTOR (dB)	ANTENNA HEIGHT (cm)	TABLE ANGLE (Degree)	REMARK
40.53	28.69	45.49	40	-11.31	13.55	0.67	31.02	100	121	Peak
61.32	25.03	43.79	40	-14.97	11.82	0.83	31.41	100	184	Peak
185.79	25.7	45.58	43.5	-17.8	10.33	1.53	31.74	100	110	Peak
511.4	19.53	30.73	46	-26.47	17.57	2.82	31.59	100	162	Peak
676.6	24	31.95	46	-22	20.54	3.34	31.83	100	259	Peak
774.6	25.54	31.4	46	-20.46	21.87	3.63	31.36	100	230	Peak
	Α	NTENN	A POLAR	ITY & TE	EST DISTA	NCE: V	ERTICAL	. AT 3 M		
FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	READ LEVEL (dBuV)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA FACTOR (dB/m)	CABLE LOSS (dB)	PREAMP FACTOR (dB)	ANTENNA HEIGHT (cm)	TABLE ANGLE (Degree)	REMARK
40.53	35.13	51.93	40	-4.87	13.55	0.67	31.02	100	193	Peak
67.8	26.8	46.65	40	-13.2	11	0.88	31.73	100	117	Peak
183.9	19.95	39.74	43.5	-23.55	10.46	1.52	31.77	100	102	Peak
591.9	22.01	31.7	46	-23.99	19.41	3.06	32.16	100	245	Peak
673.1	23.11	31.11	46	-22.89	20.49	3.33	31.82	100	281	Peak
755.7	25.64	31.83	46	-20.36	21.6	3.59	31.38	100	294	Peak

REMARKS:

1. Emission Level = Read Level + Antenna Factor + Cable Loss - Preamp Factor

Margin Value = Emission Level - Limit Value



4.2 CONDUCTED EMISSION MEASUREMENT

4.2.1 LIMITS OF CONDUCTED EMISSION MEASUREMENT

FREQUENCY OF EMISSION (MHz)	CONDUCTED LIMIT (dBµV)				
	Quasi-peak	Average			
0.15 ~ 0.5 0.5 ~ 5 5 ~ 30	66 to 56 56 60	56 to 46 46 50			

NOTE: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

4.2.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	DATE OF CALIBRATION	DUE DATE OF CALIBRATION
Test Receiver ROHDE & SCHWARZ	ESCS30	100288	Nov. 09, 2012	Nov. 08, 2013
RF signal cable Woken	5D-FB	Cable-HYCO2-0 1	Dec. 28, 2012	Dec. 27, 2013
LISN ROHDE & SCHWARZ (EUT)	ESH2-Z5	100100	Dec. 21, 2012	Dec. 20, 2013
LISN ROHDE & SCHWARZ (Peripheral)	ESH3-Z5	100312	Jul. 02, 2013	Jul. 01, 2014
Software ADT	BV ADT_Cond_ V7.3.7.3	NA	NA	NA

NOTE: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in HwaYa Shielded Room 2.

3. The VCCI Site Registration No. is C-2047.



4.2.3 TEST PROCEDURES

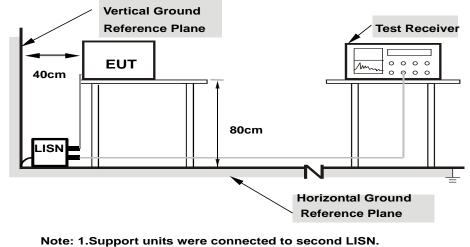
- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The frequency range from 150kHz to 30MHz was searched. Emission levels under (Limit 20dB) was not recorded.

NOTE: All modes of operation were investigated and the worst-case emissions are reported.

4.2.4 DEVIATION FROM TEST STANDARD

No deviation.

4.2.5 TEST SETUP



2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.2.6 EUT OPERATING CONDITIONS

Same as 4.1.6.

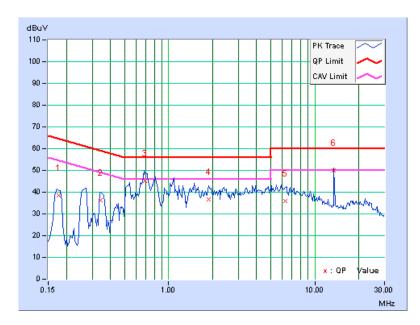


4.2.7 TEST RESULTS

PHA	SE	Line	ne 1 6dB BANDWIDTH 9kHz			2					
Freq. Corr. Reading Value Emission Level Limit Margin											
No	Freq.	Corr. Factor		V		on Levei (uV)]		nit (uV)]	1		rgin B)
	[MHz]	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	A		Q.P.	AV.
1	0.17734	0.17	38.33	31.98	38.50	32.15	64.61	54.	.61	-26.11	-22.46
2	0.34141	0.20	35.92	23.75	36.12	23.95	59.17	49.	.17	-23.05	-25.22
3	0.69297	0.24	44.86	33.88	45.10	34.12	56.00	46.	.00	-10.90	-11.88
4	1.88281	0.28	36.57	25.51	36.85	25.79	56.00	46.	.00	-19.15	-20.21
5	6.28516	0.39	35.49	25.01	35.88	25.40	60.00	50.	.00	-24.12	-24.60
6	13.55859	0.50	49.37	45.41	49.87	45.91	60.00	50.	.00	-10.13	-4.09

REMARKS:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

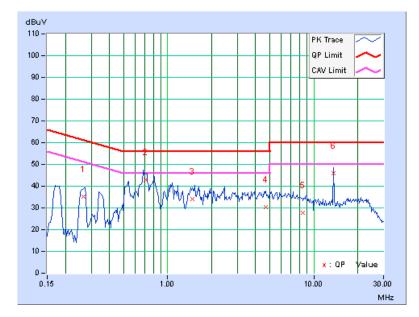




PHA	SE	Line	2		6	6dB BANDWIDTH 9kl			Ηz		
	Freq.	Corr.	Readin	Reading Value Emis			Lir	nit	Margin		
No	• • •	Factor		(uV)]		(uV)]		(uV)]		B)	
	[MHz]	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	
1	0.26719	0.20	34.93	27.83	35.13	28.03	61.20	51.20	-26.07	-23.17	
2	0.70469	0.24	42.66	33.89	42.90	34.13	56.00	46.00	-13.10	-11.87	
3	1.47266	0.25	33.96	25.20	34.21	25.45	56.00	46.00	-21.79	-20.55	
4	4.69141	0.40	30.05	23.93	30.45	24.33	56.00	46.00	-25.55	-21.67	
5	8.37109	0.46	27.46	20.94	27.92	21.40	60.00	50.00	-32.08	-28.60	
6	13.56250	0.57	45.35	41.56	45.92	42.13	60.00	50.00	-14.08	-7.87	

REMARKS:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





4.3 FREQUENCY STABILITY

4.3.1 LIMITS OF FREQUENCY STABILITY MEASUREMENT

The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of –20 degrees to 50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C.

4.3.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	DATE OF CALIBRATION	DUE DATE OF CALIBRATION	
R&S SPECTRUM ANALYZER	FSP40	100039	Jan. 31, 2013	Jan. 30, 2014	
WIT STANDARD TEMPERATURE AND HUMIDITY CHAMBER	TH-4S-C	W981030	Jun. 10, 2013	Jun. 09, 2014	

NOTE: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

4.3.3 TEST PROCEDURE

- a. The EUT was placed inside the environmental test chamber and powered by nominal DC voltage.
- b. Turn the EUT on and couple its output to a spectrum analyzer.
- c. Turn the EUT off and set the chamber to the highest temperature specified.
- d. Allow sufficient time (approximately 30 min) for the temperature of the chamber to stabilize, turn the EUT on and measure the operating frequency after 2, 5, and 10 minutes.
- e. Repeat step 2 and 3 with the temperature chamber set to the lowest temperature.
- f. The test chamber was allowed to stabilize at +20 degree C for a minimum of 30 minutes. The supply voltage was then adjusted on the EUT from 85% to 115% range and the frequency record.

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4.3.6 EUT OPERATING CONDITION

Same as Item 4.1.6.



4.3.7 TEST RESULTS

	FREQUEMCY STABILITY VERSUS TEMP.												
		0 MIN	NUTE	2 MIN	2 MINUTE		NUTE	10 MINUTE					
темр. (℃)	POWER SUPPLY (Vdc)	Measured Frequency	Frequency Drift	Measured Frequency	Frequency Drift	Measured Frequency	Frequency Drift	Measured Frequency	Frequency Drift				
		(MHz)	%	(MHz)	%	(MHz)	%	(MHz)	%				
55	3.8	13.560018	0.0001	13.560048	0.0004	13.560033	0.0002	13.560039	0.0003				
50	3.8	13.560026	0.00019	13.560044	0.00032	13.560035	0.00026	13.560039	0.00029				
40	3.8	13.560035	0.00026	13.560044	0.00032	13.560036	0.00027	13.560043	0.00032				
30	3.8	13.560036	0.00027	13.560056	0.00041	13.560051	0.00038	13.560048	0.00035				
20	3.8	13.560059	0.00044	13.560054	0.00040	13.560072	0.00053	13.560072	0.00053				
10	3.8	13.560028	0.00021	13.560039	0.00029	13.560024	0.00018	13.560039	0.00029				
0	3.8	13.559954	-0.00034	13.559961	-0.00029	13.559977	-0.00017	13.559972	-0.00021				
-10	3.8	13.560008	0.00006	13.559988	-0.00009	13.559983	-0.00013	13.559985	-0.00011				
-20	3.8	13.560027	0.00020	13.560024	0.00018	13.560012	0.00009	13.56003	0.00022				
-30	3.8	13.559957	-0.00032	13.559975	-0.00018	13.559962	-0.00028	13.559959	-0.00030				

	FREQUEMCY STABILITY VERSUS VOLTAGE										
ТЕМР. (°С)	POWER SUPPLY (Vdc)	0 MINUTE		2 MINUTE		5 MINUTE		10 MINUTE			
		Measured Frequency	Frequency Drift	Measured Frequency	Frequency Drift	Measured Frequency	Frequency Drift	Measured Frequency	Frequency Drift		
		(MHz)	%	(MHz)	%	(MHz)	%	(MHz)	%		
20	4.35	13.560058	0.00043	13.560055	0.00041	13.560068	0.00050	13.560074	0.00055		
	3.8	13.560059	0.00044	13.560054	0.00040	13.560072	0.00053	13.560072	0.00053		
	3.55	13.560058	0.00043	13.560054	0.00040	13.56007	0.00052	13.560074	0.00055		



4.4 20dB BANDWIDTH

4.4.1 LIMITS OF 20dB BANDWIDTH MEASUREMENT

The 20dB bandwidth shall be specified in operating frequency band.

4.4.2 TEST INSTRUMENTS

Same as Item 4.1.2.

4.4.3 TEST PROCEDURE

The bandwidth of the fundamental frequency was measured by spectrum analyzer with 1kHz RBW and 3kHz VBW. The 20dB bandwidth is defined as the total spectrum the power of which is higher than peak power minus 20dB.

4.4.4 DEVIATION FROM TEST STANDARD

No deviation.

4.4.5 TEST SETUP

Same as Item 4.1.5.

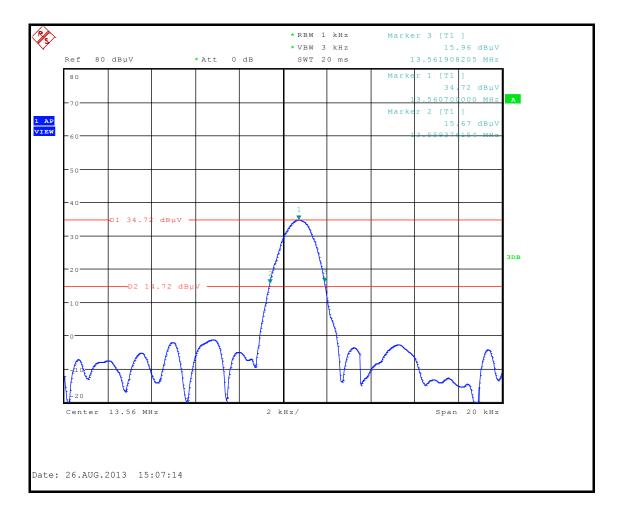
4.4.6 EUT OPERATING CONDITION

Same as Item 4.1.6.



4.4.7 TEST RESULTS

20dBc point (Low)	20dBc point (High)	Operating frequency band (MHz)	PASS/FAIL	
13.559376154 MHz	13.561908205 MHz	13.553~13.567	PASS	





5. PHOTOGRAPHS OF THE TEST CONFIGURATION

Please refer to the attached file (Test Setup Photo).



6. INFORMATION ON THE TESTING LABORATORIES

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

Linko EMC/RF Lab: Tel: 886-2-26052180 Fax: 886-2-26051924 Hsin Chu EMC/RF Lab: Tel: 886-3-5935343 Fax: 886-3-5935342

Hwa Ya EMC/RF/Safety Telecom Lab: Tel: 886-3-3183232 Fax: 886-3-3270892

Email: <u>service.adt@tw.bureauveritas.com</u> Web Site: <u>www.bureauveritas-adt.com</u>

The address and road map of all our labs can be found in our web site also.



7. APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE EUT BY THE LAB

No any modifications are made to the EUT by the lab during the test.

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